

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/067,056	HIRAI, SHINYA	
Examiner	Art Unit	
Kelly L. Jerabek	2612	

	SEARCHED				
Class	Subclass	Date	Examiner		
348	252	2/21/2006	КЈ		
	272				
	280				
	289				
	290				
	292	2/22/2006			

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Class	Subclass	Date	Examiner	
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	DATE	EXMR
IEEE	2/21/2006	KJ
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Tuan Ho	12/20/2005	
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